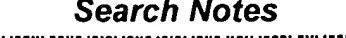


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/898,275	LEE, JONG HEON
	Examiner	Art Unit
	Jefferey F. Harold	2646

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
379	375.01	11/1/2005	JFH
379	413.01	11/1/2005	JFH
379	418	11/1/2005	JFH